



FADC System

Belle SVD 2.0 readout



Programmer's Manual

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DISCLAIMER

The FADCTF is a complex electronic system which can be damaged if handled improperly. In particular, the following guidelines must be respected by the operator. We decline any responsibility for errors, damage or injury resulting from such misuse.

- **Crate and modules belong together.**

Do not use the VME modules (FADCTF, Sequencer, PCI-Link) in a VME crate other than the one provided with the system.

The user defined $\pm V1$ and $\pm V2$ rails are used to supply special voltages to the FADCTF modules; while the Sequencer board provides $\pm 12V$ which is required by the Sparc interface. Moreover, the FADCTF modules are mechanically coded with the corresponding counterparts in the crate.

- **Always power off to change modules.**

Never remove or insert a VME module of the system when the crate power is on. Ensure that each module is fully inserted (needs some force).

The VME interface Altera (EPM7256S; 5V core) is not specified for hot-swapping. It can take damage by contention between logic levels and power supply during plugging of the module or in case of bad contact.

- **Double-check the VME base addresses.**

It is extremely important that each FADCTF module has the correct VME base address set.

Altera programming and I/O interfacing to neighboring modules as used by the LO trigger processor rely on the correct VME base address setting which corresponds to the mechanical coding. If the address is wrong and outputs of two modules are connected, both modules will be damaged by overheating.

- **Do not use the JTAG feature.**

Programming Altera devices on the FADCTF modules is for experts only.

All Altera devices (except for the VME protocol interface) can be programmed by the JTAG bus that is accessible by VME. Obviously, much harm can be done by improper use of this feature. The worst case is to blow up all Altera devices on the board.

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1 Contact

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2 Overview

This document describes the VME connectivity of the FADC system components. Please refer to the FADCTF User's Manual for an introduction to the FADCTF system hardware.

The VME base address of the Sequencer module is called `S_BASE`, and the base address of one FADCTF module is `F_BASE`.

2.1 Power on

2.1.1 Load Altera chips

When the crate power is switched on, the Altera chips are loaded from EEPROMs or flash memories. However, the supply voltages may still ramp up and thus may cause errors during the loading process. Thus, it is recommended to re-load the Altera chips on the FADCTF boards by the two VME commands

```
FADCTF  F_BASE+0x2c0000  D00=1      start Altera loading
```

(wait >50µs)

```
FADCTF  F_BASE+0x2c0000  D00=0      stop Altera loading
```

The actual loading process will take a few seconds, during which no VME commands shall be issued.

2.1.2 Select clock source

Most of the logic units on the FADCTF will need a clock for proper functioning. Thus, before sending any further VME commands, the clock source should be set in the Sequencer. Its default condition after power-on is to transparently repeat all TTM signals including the clock. However, it is recommended to reset the Sequencer and set the desired clock source by VME:

```
Seq      S_BASE+0x00          D30=1      Sequencer FIFO reset (clear)
```

```
Seq      S_BASE+0x00          D31=1      Sequencer reset (see 5.2.1, p. 21)
```

```
Seq      S_BASE+0x08          D00=ttm    TTM or ext. clock (see 5.2.2, p. 22)
```

Seq S_BASE+0x0c D00=q ext. or quartz clock (see 5.2.2, p. 22)

NB: The switch on the Sequencer front panel has to be in „INT“ (left) position and internal mode (see 5.2.1, p. 21) has to be selected to enable the internal quartz clock. The TTM clock can only be chosen in external mode (power-on default), while the front panel input clock is selectable regardless of switch or mode.

2.1.3 Reset FADCTF

Although the FADCTF should be in normal data taking mode by default after power-on, it is recommended to send a general reset by VME which definitely sets it to that state:

FADCTF F_BASE+0x3c0000 D31...00=x FADCTF reset (see 4.2.1, p. 11)

NB: The reset signal is issued by any write operation to this VME address regardless of the data bits.

2.2 Modes of operation

After everything is properly initialized, the user must decide in which mode the FADCTF shall be put. In the final environment of the FADC system, there will be 3 different modes of operation described below.

2.2.1 Normal data taking

The normal data acquisition under the control of the TTM system and with PCI-Link output is the default condition after power-on or after a general reset (GENRES). Thus, no more settings are required.

2.2.2 External test mode (nibble or transparent mode)

Each VA1TA will present one channel in transparent mode that is digitized and read out by the FADC system. This mode requires clock, start and ADC clock signals from the TTM system (EFT should be low). The following VME registers are linked to the external test mode:

FADCTF F_BASE+0x018800 D02=1 external test mode (see 4.2.2.1.2, p. 14)

FADCTF F_BASE+DAPx D01=0|1 5 or 20MHz (see 4.2.2.2.3, p. 15)

NB: The sample taking clock has to be set for each DAP unit (addresses: DAP 2 / 3 / 4 = 0x001000 / 0x002000 / 0x003000, DAP 5 / 6 / 7 = 0x005000 / 0x006000 / 0x007000).

2.2.3 Internal test mode

This mode is used to find potential errors within a module or a crate and does not require TTM system or the PCI-Link. Instead, one can use VME commands on the Sequencer to create the necessary input signals. First of all, the Sequencer must be set into the internal test mode (requires the front panel switch in “INT” (left) position):

Seq S_BASE+0x00 D00=1 Sequencer internal mode (see 5.2.1, p. 21)

The signals for a readout cycle can be generated by the Sequencer using

Seq S_BASE+0x04 D00=1 Generate readout cycle (see 5.4.1, p. 23)

NB: There are additional options for the readout cycle which are described in chapter 5.4.1, p. 23.

2.3 VME implementation

Many registers allow write and read operations, but in most cases these functions are not accessing the same registers. Thus, writable registers usually cannot be read back (except for the TIP1_B register in the Timing Control Unit of the FADCTF).

We are sorry that the VME implementation is a bit confusing and not really intuitive, because it is historically grown. During the development, features were added continuously, but we refrain from re-designing the protocol since this would have large implications on existing software.

2.4 VME command notation

The VME commands shown here are in the National Instruments CVI notation, which consists of the write command

```
VXIout (type, address, bytes, data)
```

and the similar read command

```
VXIin (type, address, bytes, &data)
```

The first argument specifies the type of VME transfer (address modifier), followed by the address (up to 32 bits), the number of bytes to be transferred (1, 2 or 4) and the data word (up to 32 bits) to be written or read. With this knowledge, the input/output functions can be easily translated to match the requirements of other systems (such as the Sparc CPU).

All surrounding code is written in plain C language.

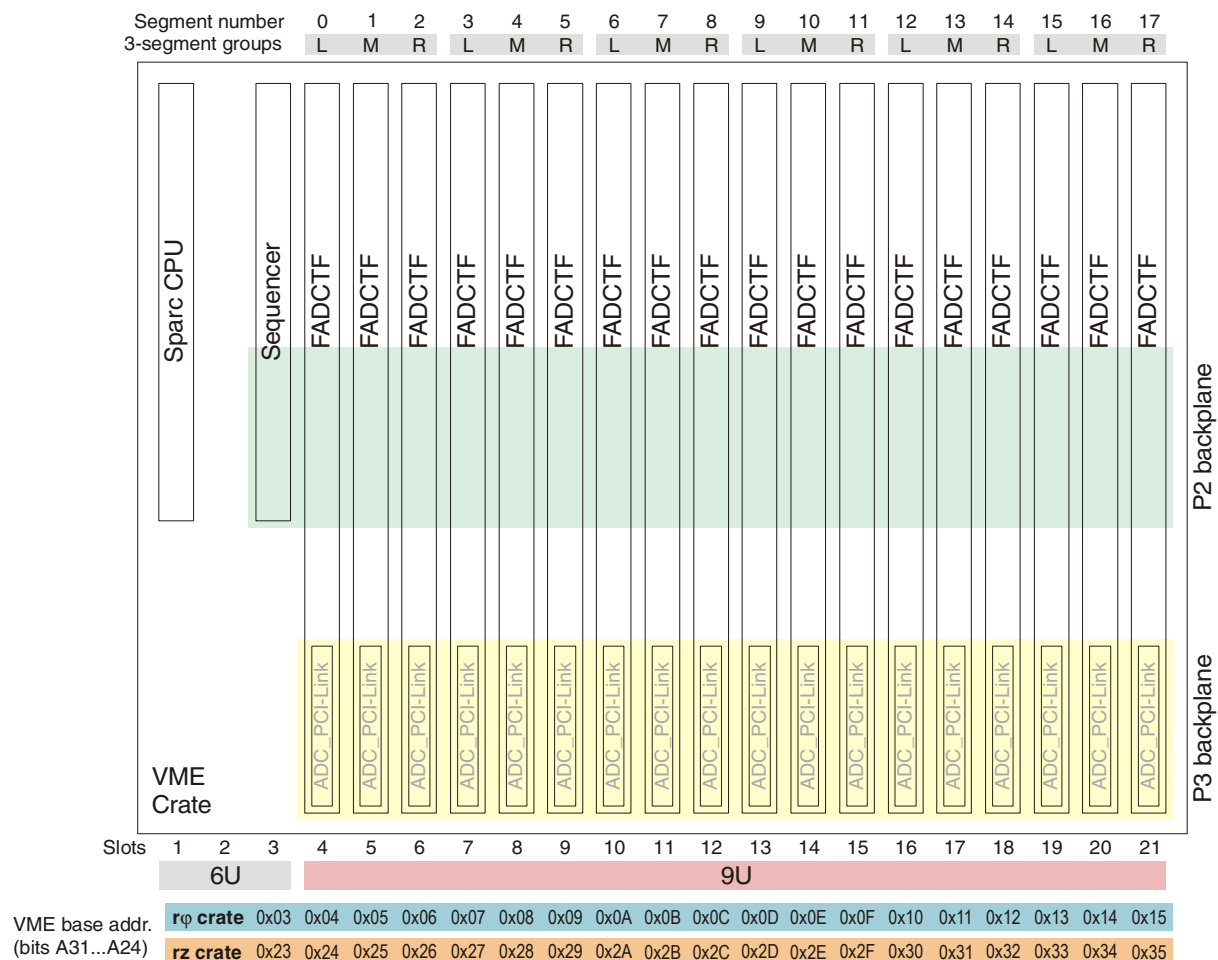
3 Addresses and coding

3.1 VME base addresses

Each VME module will get its own A32 address space. Basically, the numbering scheme will follow the slot numbers for what concerns the Sequencer and the FADCTF modules. Moreover, we have to distinguish two crates (rφ and rz).

Crate	VME base address bits A31...A24
rφ	Slot number
rz	Slot number + 0x20

Since the Sequencer must be inserted in slot 3, it will have the base address 0x03000000 in the rφ crate and 0x23000000 in the rz crate. The illustration below gives an overview of all base addresses.



3.2 Mechanical coding

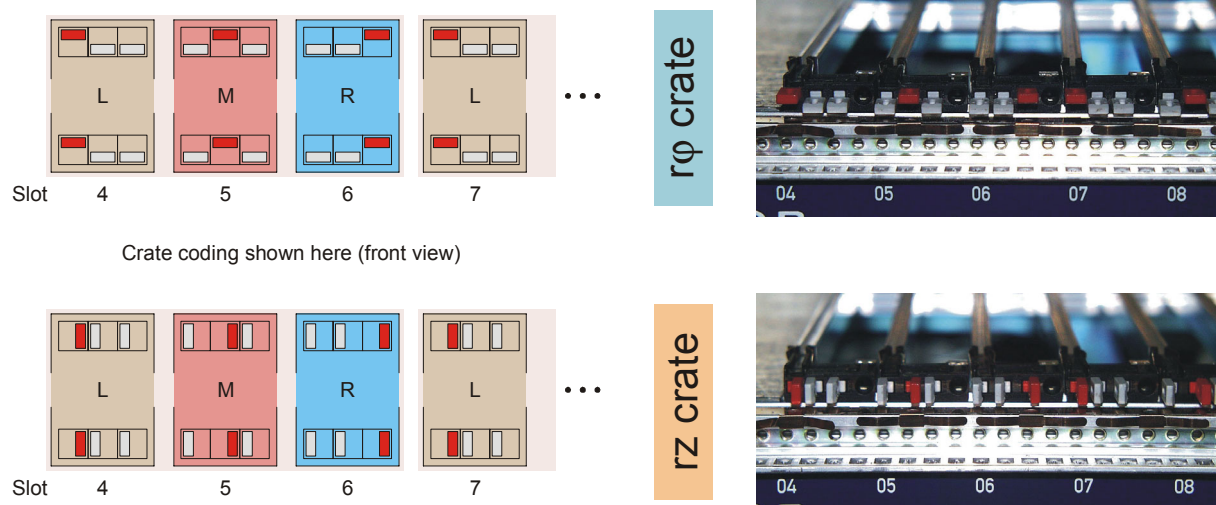
3.2.1 Crates

Mechanical coding has been introduced to prevent the modules from wrong insertion. The reason for this are the LO (and optionally L1.5) trigger processor interconnections: Two output buses must not be connected together or the Altera chips will take damage from overheating.

Plastic pins are inserted at each slot of the crate (3 at bottom and 3 on top) and on the counterpart of the FADCTF modules. By this method, a module can only be inserted in a matching slot.

In total, there are 6 different LO firmware versions: One for Left, Middle and Right modules each in rφ and rz crates. This is reflected by 6 different mechanical codings as shown below. With equal codes for top and bottom pins for each slot, one (mechanically equal) red pin indicates is detached at left, middle or right position to indicate the type of module. Module (or segment) triplets are equal, and so is the mechanical coding, which is identical e.g. for slots 4,7,10,13,16,19 as well as the LO processor.

The code pins are oriented horizontally and vertically in rφ and rz crates, respectively.

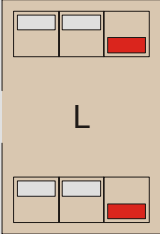
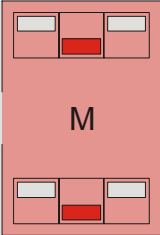
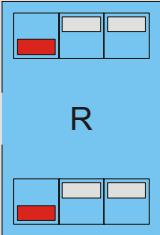
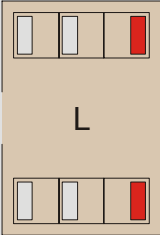
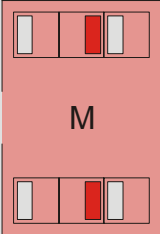
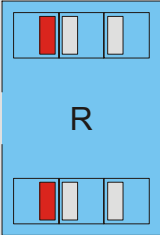


Crate coding shown here (front view)

IMPORTANT: The pin coding in the VME crates must never be removed since it prevents wrong insertion of modules which can damage the LO processor Altera. We decline any responsibility for the consequences of such action.

3.2.2 FADCTF modules

The FADCTF modules are be equipped with pins that match the crate coding. All valid combinations of slot number, coding, module type and VME base address are shown in the table below. NB: The codes are shown when looking from the rear (VME connector side) towards the back of the FADCTF front panel.

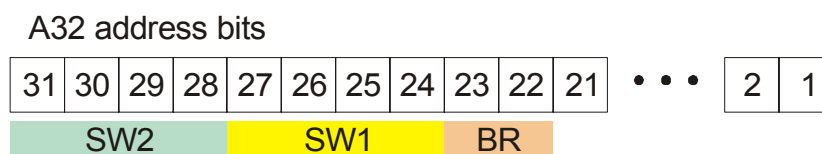
Crate	Coding (rear view)	Slot	VME base address
rφ crate	 <p>L</p>	4	0x04
		7	0x07
		10	0x0a
		13	0x0d
		16	0x10
		19	0x13
	 <p>M</p>	5	0x05
		8	0x08
		11	0x0b
		14	0x0e
		17	0x11
		20	0x14
	 <p>R</p>	6	0x06
		9	0x09
		12	0x0c
15		0x0f	
18		0x12	
21		0x15	
rZ crate	 <p>L</p>	4	0x24
		7	0x27
		10	0x2a
		13	0x2d
		16	0x30
		19	0x33
	 <p>M</p>	5	0x25
		8	0x28
		11	0x2b
		14	0x2e
		17	0x31
		20	0x34
	 <p>R</p>	6	0x26
		9	0x29
		12	0x2c
15		0x2f	
18		0x32	
21		0x35	

4 FADCTF

4.1 Address space

Each module within a crate will have its own A32 address space representing a contiguous data block of 16MB (bits A23...A0).

Bits A31...A24 of the base address can be selected by two switches which are located close to the rear end of the PCB between The VME connectors P1 and P2. Each switch provides a range of 0x0...0xF, resulting in a total space of 256 different addresses. Switch SW2 serves the highest 4 bits, while SW1 sets bits A27...A24, as indicated in the drawing below.



The address bits A23 and A22 are reserved for the broadcast mode. If these bits are both set, every FADCTF module reacts regardless of address bits A31...A24. This is useful e.g. to generate a global, synchronous test pulse or to globally turn on/off the Fast-Or counters.

Let's call a module's base address `F_BASE`. All VME addresses in the tables within this document are shown in HEX format.

4.2 Bus systems

4.2.1 Overview

A FADCTF module has a total number of 7 internal buses which are all accessible by VME.

- 2 parallel buses (Local Bus 1 and 2)
- 2 serial buses (DAC and LO processor)
- 3 JTAG buses

These bus systems and their VME connectivity will be described in detail below.

A general reset (RES) issued by VME affects the parallel buses 1 and 2 and puts the module into a state ready for normal data taking; i.e. all registers are set for that purpose.

The VME addresses (relative to `F_BASE`) of the individual buses are shown in the table below.

Bus	VME address (rel to F_BASE)	Description
Local Bus 1	0x000000	Data Processors, Timing Control, L1.5 Proc.
Local Bus 2	0x020000	Final Memory
Serial Bus 1	0x040000	Write/read LO processor
STROSEQ1	0x080000	Strobe for Sequencer V1 (obsolete)
Serial Bus 2	0x0c0000	Load DACs
JTAG Bus 1	0x100000	JTAG write IOP
	0x140000	JTAG read IOP
JTAG Bus 2	0x180000	JTAG write DAPs
	0x1c0000	JTAG read DAPs
JTAG Bus 3	0x240000	JTAG write TIP
	0x280000	JTAG read TIP
NCONFIG	0x2c0000	Reload Alteras from EEPROMs
RES	0x3c0000	Strobe for general Reset (Data Processors, Timing Control, L1.5, Final Memory, Local Buses 1 & 2)

4.2.2 Local Bus 1 — (A17...A21)=0

This bus contains of 16-bit wide address and data lines, address strobe, write strobe, read strobe and the general reset lines. It is accessible by VME with the address lines (A17...A21)=0 and communicates with the Timing Control Unit (TIP1), the Data Processors (DAPx) and the (optional) simple L1.5 Trigger Processor (TRP1).

A general reset is issued by a write operation to the VME address F_BASE + 0x3c0000.

The table below shows an overview of all devices on Local Bus 1; details are given on the following pages.

	VME bus addr bits offset from E_BASE	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	Data/Meaning
DAP2	0x001000	0	0	0	0	1	CH:#	ME:#										
DAP3	0x002000	0	0	0	1	0	CH:#	ME:#										
DAP4	0x003000	0	0	0	1	1	CH:#	ME:#										READOUT EVENTBUFFER FIFOS
DAP5	0x005000	0	0	1	0	1	CH:#	ME:#										
DAP6	0x006000	0	0	1	1	0	CH:#	ME:#										
DAP7	0x007000	0	0	1	1	1	CH:#	ME:#										
THPD2	0x009000	0	1	0	0	1	CH:#	X	X									seven bit address range
THPD3	0x00a000	0	1	0	1	0	CH:#	X	X									seven bit address range
THPD4	0x00b000	0	1	0	1	1	CH:#	X	X									WRITE AND READ THRESH+PED RAM
THPD5	0x00d000	0	1	1	0	1	CH:#	X	X									10 bit data
THPD6	0x00e000	0	1	1	1	0	CH:#	X	X									seven bit address range
THPD7	0x00f000	0	1	1	1	1	CH:#	X	X									seven bit address range
DAP2_REG	0x011000	1	0	0	0	1	CH:#											(16-bit counters)
DAP3_REG	0x012000	1	0	0	1	0	CH:#											READ FAST-OR TRIGGER COUNTER
DAP4_REG	0x013000	1	0	0	1	1	CH:#											WRITE DAP REG (without CH#; common to all 4 channels)
DAP5_REG	0x015000	1	0	1	0	1	CH:#											D0=0: positive VA1TA signals, 1=negative signals
DAP6_REG	0x016000	1	0	1	1	0	CH:#											D1=0: 5MHz ADC readout, 1=20MHz ADC readout
DAP7_REG	0x017000	1	0	1	1	1	CH:#											
TRD2	0x019000	1	1	0	0	1												
TRD3	0x01a000	1	1	0	1	0												
TRD4	0x01b000	1	1	0	1	1												READ L1.5 hitmap DATA
TRD5	0x01d000	1	1	1	0	1												4 x 128 bit deep FIFO
TRD6	0x01e000	1	1	1	1	0												
TRD7	0x01f000	1	1	1	1	1												
TIP1	0x018000	1	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	TIMING CONTROL ALTERA
																		D0=1: use internal event number; 0: use TTM ev.nr.
																		D1=1: increase internal event number
																		D4=1: disable DAP->final memory transfer upon L1.5
TIP1	0x018800	1	1	0	0	0	1	0	0	0	0	0	0	0	0	0	0	TIMING CONTROL ALTERA
																		D0=1: enable Fast-Or counters; 0: disable counters
																		D1=1: reset Fast-Or counters
																		D2=1: enable external test mode
																		D3=1: generate internal start signal
																		D4=1: set test pulse high, 0: low
TRP1	0x01c000	1	1	1	0	0	X	X	X	X	X	X	X	X	X	X	X	L1.5 TRIGGER ALTERA (unused)

4.2.2.1 Timing Control – TIP1

4.2.2.1.1 Event number and DAP/Final Memory

VME bus addr/data bits

16

15	14	13	12
----	----	----	----

11	10	9	8
----	----	---	---

7	6	5	4
---	---	---	---

3	2	1	0
---	---	---	---

offset from F_BASE

Address	0x018000	1	1	0	0	0	0	0	0	0	0	0	0	0	0	0
Data	write		x	x	x	x	x	x	x	x	x	c	x	x	b	a

- a=0 use TTM event number
- a=1 use internal event number (for test purposes)

- b=0 --
- b=1 increase internal event number (useful only with a=1)

- c=0 normal DAP->final memory transfer upon L1.5 accept
- c=1 disable DAP->final memory transfer ("NO_AUTOREAD", for test purposes);
in this mode the DAP event buffer FIFOs can be read out by VME (using ME=0),
otherwise the data would have been transferred to the Final Memory

4.2.2.1.2 Fast-Or counter, ext. test mode, start, test pulse

VME bus addr/data bits

16

15	14	13	12
----	----	----	----

11	10	9	8
----	----	---	---

7	6	5	4
---	---	---	---

3	2	1	0
---	---	---	---

offset from F_BASE

Address	0x018800	1	1	0	0	0	0	1	0	0	0	0	0	0	0	0
Data	write		x	x	x	x	x	x	x	x	x	e	d	c	b	a
Data	read		x	x	x	x	x	x	x	x	x	e	d	c	b	a

- a=0 disable Fast-Or counters (global line to all DAPs)
- a=1 enable Fast-Or counters

- b=0 --
- b=1 reset Fast-Or counters (global line to all DAPs)

- c=0 normal data taking
- c=1 enable external test mode (nibble or transparent mode)

- d=0 --
- d=1 generate internal start signal and thus initiate storage of 128 ADC samples

- e=0 set test pulse LOW |NB: test pulse is AC-coupled
- e=1 set test pulse HIGH

NB: The 16-bit values written to the this register can be read back on the same address.
(intended for testing Local Bus 1)

4.2.2.2 Signal Processing – DAPx

4.2.2.2.1 Read ADC event buffer FIFOs

		VME bus addr bits																
		16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
		offset from F_BASE																
DAP2	Address	0x001000	0	0	0	0	1	CH :#	ME :#	0	0	0	0	0	0	0	0	0
DAP3	Address	0x002000	0	0	0	1	0	CH :#	ME :#	0	0	0	0	0	0	0	0	0
DAP4	Address	0x003000	0	0	0	1	1	CH :#	ME :#	0	0	0	0	0	0	0	0	0
DAP5	Address	0x005000	0	0	1	0	1	CH :#	ME :#	0	0	0	0	0	0	0	0	0
DAP6	Address	0x006000	0	0	1	1	0	CH :#	ME :#	0	0	0	0	0	0	0	0	0
DAP7	Address	0x007000	0	0	1	1	1	CH :#	ME :#	0	0	0	0	0	0	0	0	0
	Data	read			sto	sta	e	e	e	e	d	d	d	d	d	d	d	d

sto stop bit
 sta start bit
 e 4-bit event number
 d 10-bit ADC data
 CH 2-bit channel number (one of 4 inputs)
 ME 2-bit FIFO number (one of 4 FIFOs)

4.2.2.2.2 Read/Write Pedestal+Threshold memory

		VME bus addr bits																
		16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
		offset from F_BASE																
THPD2	Address	0x009000	0	1	0	0	1	CH :#	0	0	a	a	a	a	a	a	a	a
THPD3	Address	0x00a000	0	1	0	1	0	CH :#	0	0	a	a	a	a	a	a	a	a
THPD4	Address	0x00b000	0	1	0	1	1	CH :#	0	0	a	a	a	a	a	a	a	a
THPD5	Address	0x00d000	0	1	1	0	1	CH :#	0	0	a	a	a	a	a	a	a	a
THPD6	Address	0x00e000	0	1	1	1	0	CH :#	0	0	a	a	a	a	a	a	a	a
THPD7	Address	0x00f000	0	1	1	1	1	CH :#	0	0	a	a	a	a	a	a	a	a
	Data	write		0	0	0	0	0	0	t	t	t	t	t	t	t	t	t
	Data	read		0	0	0	0	0	0	t	t	t	t	t	t	t	t	t

t 10-bit threshold data
 a 7-bit strip (channel) number (0...127)
 CH 2-bit channel number (one of 4 inputs)

4.2.2.2.3 Read Fast-Or trigger counters

		VME bus addr bits																
		16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
		offset from F_BASE																
DAP2_REG	Address	0x011000	1	0	0	0	1	CH :#	0	0	0	0	0	0	0	0	0	0
DAP3_REG	Address	0x012000	1	0	0	1	0	CH :#	0	0	0	0	0	0	0	0	0	0
DAP4_REG	Address	0x013000	1	0	0	1	1	CH :#	0	0	0	0	0	0	0	0	0	0
DAP5_REG	Address	0x015000	1	0	1	0	1	CH :#	0	0	0	0	0	0	0	0	0	0
DAP6_REG	Address	0x016000	1	0	1	1	0	CH :#	0	0	0	0	0	0	0	0	0	0
DAP7_REG	Address	0x017000	1	0	1	1	1	CH :#	0	0	0	0	0	0	0	0	0	0
	Data	write		x	x	x	x	x	x	x	x	x	x	x	x	b	a	
	Data	read		c	c	c	c	c	c	c	c	c	c	c	c	c	c	c

a=0 positive VA1TA signals
 a=1 negative VA1TA signals
 b=0 5MHz ADC readout
 b=1 20MHz ADC readout
 c 16-bit Fast-Or trigger counter (enable/disable/reset in TIP1)
 NB: Fast-Or is a gate to the 20MHz clock for the counter, thus counting depends on Fast-Or width

common to all 4 input channels (set CH=00)

4.2.2.2.4 Read hitmap L1.5 data

	VME bus addr bits	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	offset from F_BASE																	
TRD2	Address	0x019000	1	1	0	0	1	0	0	0	0	0	0	0	0	0	0	0
TRD3	Address	0x01a000	1	1	0	1	0	0	0	0	0	0	0	0	0	0	0	0
TRD4	Address	0x01b000	1	1	0	1	1	0	0	0	0	0	0	0	0	0	0	0
TRD5	Address	0x01d000	1	1	1	0	1	0	0	0	0	0	0	0	0	0	0	0
TRD6	Address	0x01e000	1	1	1	1	0	0	0	0	0	0	0	0	0	0	0	0
TRD7	Address	0x01f000	1	1	1	1	1	0	0	0	0	0	0	0	0	0	0	0
	Data	read		x	x	x	x		x	x	x	x		x	x	x	x	z

z serialized hitmap data for L1.5 trigger multiplexed from 4 input channels (4 x 128 bit deep FIFO)

4.2.2.3 Simple L1.5 processor

	VME bus addr bits	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	offset from F_BASE																	
Address	0x01c000	1	1	1	0	0	x	x	x	x	x	x	x	x	x	x	x	

Currently not implemented.

4.2.3 Local Bus 2 — A21=A01=1, (A20...A02)=0

This bus also uses 16-bit wide data lines. It is accessible by VME with the address lines A21=1, (A20...A02)=0, A01=1 and communicates with the Final Memory Unit (DACPR1).

4.2.3.1 Final Memory

	VME bus addr/data bits	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	offset from F_BASE																						
DACPR1	Address	0x200002	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	
	Data	write						x	x	x	x	x	x	x	x	x	x	x	x	d	c	b	a
	Data	read, a=0						x	x	x	x	x	x	x	x	x	x	x	x	x	x	x	f
	Data	read, a=1, b=0						sto	sta	e	e	e	e	du	du	du	du	du	du	du	du	du	du
	Data	read, a=1, b=1						sto	sta	ch	ch	ch	ch	dd	dd	dd	dd	dd	dd	dd	dd	dd	dd

- a=0 read FIFO empty flag
- a=1 read Final Memory FIFO
- b=0 read bits 0...15 of Final Memory (only with a=1)
- b=1 read bits 16...31 of Final Memory (only with a=1)
- c=0 & d=0 normal data output through PCI-Link
- c=1 & d=0 test mode POSTFIFO
- c=0 & d=1 test mode PREFIFO
- f FIFO empty flag (only with a=0)
- sto stop bit
- sta start bit
- e 4-bit event number
- ch channel number (0..12)
- dd 10-bit ADC data of "down" DAPs (5,6,7)
- du 10-bit ADC data of "up" DAPs (2,3,4)

When the toggle test mode is enabled, Final Memory contents are read out, but the data are replaced by alternating all zeros and all ones, thus presenting the maximum load onto the PCI-Link output lines for test purposes. Once the final memory is empty, no more 0/1 will be pushed out.

Only a half-word (16 bits) of the 32-bit data word can be read out at a time due to limitations in the I/O pins of the used Altera devices. However, since the data is stored in a FIFO, one cannot read both half-words of the same data packet, since the FIFO is already cleared by the readout of one half-word and the next readout refers to the next event data. This procedure may be subject to future changes.

The final memory 32-bit data word, as it appears on the PCI-Link output, is shown below.

31	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
PAR	0	Event #				10 bit ADC data down						STQ	STA	Channel #				10 bit ADC data up													

4.2.4 Serial Bus 1 – LO (A21...A19)=0, A18=1 and (A17...A03)=0

This serial bus is transparent to VME with the address lines (A21...A19)=0, A18=1 and (A17...A03)=0 and communicates with the LO trigger processor.

This bus is used to read the LO trigger counters, of which one simply counts the LO pulses while the other counts the VME clock gated with that LO trigger pulses. Moreover, the upper or lower half of the 16 lines of interconnection between FADCTF modules can be enabled for output. NB: This is only an additional measure to avoid shorting of two outputs. Nevertheless, the LO trigger processor Altera device must be properly configured such that the proper pins are defined as an output.

4.2.4.1 Enable/reset LO counters

VME bus addr/data bits	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
offset from F_BASE																						
Address	0x040000	0	0	0	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
Data	write							x	x	x	x	x	x	x	x	x	x	x	x	x	x	r e

- e=0 disable both counters
- e=1 enable both counters

- r=0 no reset
- r=1 (static) reset for both counters

4.2.4.2 Read L0 counters

4.2.4.2.1 Read straight L0 counter

VME bus addr/data bits		21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
offset from F_BASE																							
Address	0x040000	0	0	0	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	
Data	read							d	d	d	d	d	d	d	d	d	d	d	d	d	d	d	d

d 16-bit counter for L0 pulses

4.2.4.2.2 Read VME system clock gated L0 counter

VME bus addr/data bits		21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
offset from F_BASE																							
Address	0x040002	0	0	0	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	
Data	read							d	d	d	d	d	d	d	d	d	d	d	d	d	d	d	d

d 16-bit counter for VME system clock gated with L0 pulses

4.2.4.3 Module interconnection links

VME bus addr/data bits		21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
offset from F_BASE																							
Address	0x040006	0	0	0	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	1	
Data	write							x	x	x	x	x	x	x	x	x	x	x	x	x	x	l	u

u=0 disable output of upper half of module interconnection links
u=1 enable output of upper half of module interconnection links

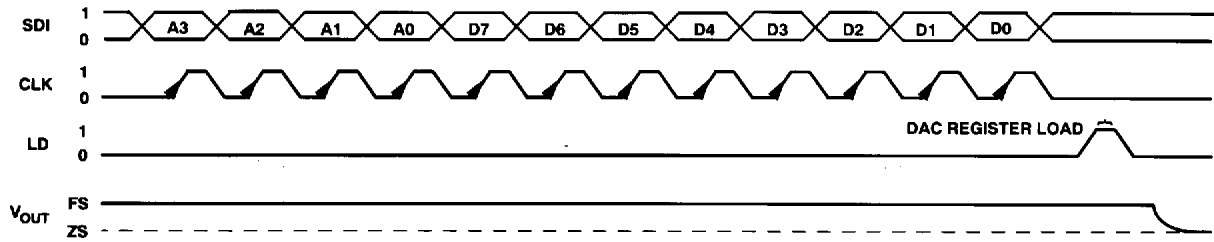
l=0 disable output of lower half of module interconnection links
l=1 enable output of lower half of module interconnection links

u=1, l=1 not allowed, both outputs are disabled

4.2.5 Serial Bus 2 – DAQ (A21...A20)=0, (A19...A18)=1 and (A17...A01)=0

This serial bus is transparent to VME with the address lines (A21...A20)=0, (A19...A18)=1 and (A17...A01)=0 and communicates with the DACs for the baseline shift of each input channel.

The 8-bit DACs used on the FADCTF boards are four Analog Devices DAC8841 with 8 outputs each. They have serial address/data and clock lines and need a strobe signal to set the output. The graph below shows a load cycle, where the DAC expects 4 address bits followed by 8 data bits and finally a load signal which actually executes the request.



Moreover, the DACs can be set to the central value (0x80) when a signal is applied to the Preset input.

The address/data, clock and preset lines are common to all four DACs, only the Load strobes are individual. Due to historical reasons, the first and last DACs are only utilized by 50%.

The matching between analog inputs (1...24) and DACs (8 channels each) can be found in the table below. The input numbering scheme follows the drawing in the FADC User's Manual (top to bottom).

Input	DAC
INP1-4	DAC 1
INP5-8	DAC 2
INP9-12	
INP13-16	DAC 3
INP17-20	
INP21-24	DAC 4

As mentioned above, only 4 out of 8 outputs are used on DAC 1 and DAC 4.

The VME address map is shown below:

VME bus addr/data bits		21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
offset from F_BASE																							
DAC	Address	0x0c0000	0	0	1	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
	Data	write						x	x	x	x	x	x	x	x	ld4	ld3	ld2	ld1	p	x	c	s

- s address/data line (SDI)
- c clock line (CLK)
- p preset all DAC outputs to 0x80
- ld1 load strobe DAC1 (INP1-4)
- ld2 load strobe DAC1 (INP5-12)
- ld3 load strobe DAC1 (INP13-20)
- ld4 load strobe DAC1 (INP21-24)

Sample Function: Set a specific DAC to a specified 8 bit value.

```
void LOAD_DAC8841(int inp, int ivalue)
// inp    = 1...24   (corresponding input channel)
// ivalue = 0...255 (8-bit DAC value)
{
    int i;

    /* Send serial address */
    for (i=0;i<4;i++)
    {
        VXIout(3,F_BASE+DAC_Strobe,2,(((inp+3)&7)+1) & (8>>i)) ? 3 : 2);
    }

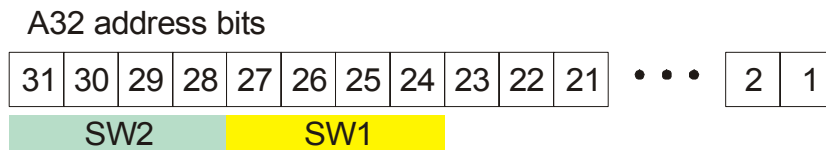
    /* Send serial data value */
    for (i=0;i<8;i++)
    {
        VXIout(3, F_BASE+DAC_Strobe, 2, (ivalue & (128>>i)) ? 3 : 2);
    }

    /* Load DAC value */
    VXIout (3, F_BASE+DAC_Strobe, 2, 0x10<<((inp+3)>>3));
}
```

5 Sequencer

5.1 Address Space

Very similar to the FADCTF modules, the Sequencer will have its own A32 address space representing a contiguous data block of 16MB (bits A23...A0). The highest 8 address bits can be selected by two hex switches on the PCB, which are located close to the rear end between the P1 and P2 connectors.



The type of VME transfer should be set for non-privileged 32 bit data access. Concerning the address modifier lines, only AM5=0 (32 bit data) is required, we don't care about AM0...AM4.

Let's call the base address of the Sequencer S_BASE .

5.2 General functions

There is an "int"/"ext" switch on the Sequencer front panel. As long as it is set to "ext" (right) position, the Sequencer will only repeat the TTM signals regardless of the VME register settings. However, it is possible to select the clock source to either TTM or the LEMO front panel input. The latter expects TTL levels and has an adjustable threshold between 550 and 2950mV.

Alternatively, the internal quartz clock (and the standalone test functions) can only be enabled if the switch is in "int" position.

5.2.1 Reset, TTM or standalone

VME bus addr bits	31	30	29	28	...	11	10	9	8	7	6	5	4	3	2	1	0
offset from S_BASE																	
Address	0x00				0 0 0 0				0 0 0 0				0 0 0				
Data	write	sr	fr	x	x	x	x	x	x	x	x	x	x	x	x	x	i

sr=0 --
sr=1 Sequencer reset

fr=0 --
fr=1 FIFO reset (clear)

i=0 external mode: repeat/distribute TTM signals
i=1 internal mode: generate all signals by VME triggered sequencer
requires front-panel switch in "int" (left) position

5.2.2 Clock source

VME bus addr bits		31	30	29	28	...	11	10	9	8	7	6	5	4	3	2	1	0		
offset from S_BASE																				
Address	0x08						0	0	0	0		0	0	0	0		1	0	0	
Data	write	x	x	x	x		x	x	x	x		x	x	x	x		x	x	x	ttm

Address	0x0c						0	0	0	0		0	0	0	0		1	1	0	
Data	write	x	x	x	x		x	x	x	x		x	x	x	x		x	x	x	q

Clock source selection in external mode (either set by switch or VME):

- ttm=0 use TTM clock
- ttm=1 use front panel clock input

Clock source selection in internal mode (set by switch and VME):

- q=0 use front panel clock input
- q=1 use internal quartz oscillator

The table below gives a summary which conditions must be met to select a specific clock source. “—” indicates that this mode is not possible. The clock source is selected by one of ttm or q registers, where the other one is irrelevant. Example: To select the quartz oscillator, internal mode must be enabled both on the front panel switch and by VME, and q set to 1, while ttm is “don’t care”.

Front panel switch	VME mode (ADDR=0x00)	Clock source (ADDR=0x08/0x0c)		
		TTM	Front panel	Quartz
INT <input checked="" type="checkbox"/> EXT	don't care	ttm=0	ttm=1	—
INT <input type="checkbox"/> EXT <input checked="" type="checkbox"/>	External, i=0	ttm=0	ttm=1	—
INT <input type="checkbox"/> EXT <input type="checkbox"/>	Internal, i=1	—	q=0	q=1

5.3 TTM L1.5 accept

The Sequencer can be used to generate a L1.5 accept (“Reject”) signal, which is sent to the TTM with a custom cable. The pulse is then transmitted over the TTM/Sequencer/P2 backplane.

VME bus addr bits		31	30	29	28	...	11	10	9	8	7	6	5	4	3	2	1	0		
offset from S_BASE																				
Address	0x3c						0	0	0	0		0	0	1	1		1	1	0	
Data	write	x	x	x	x		x	x	x	x		x	x	x	x		x	x	x	r

- r=0 --
- r=1 generate L1.5 accept pulse on TTM_IO pins 27 and 28 (for test purposes)

5.4 Standalone test functions

Please note that the internal mode only becomes effective if the front panel switch is set to “int” (left) position.

5.4.1 Normal readout cycle(s)

		VME bus addr bits				...											
		31	30	29	28	11	10	9	8	7	6	5	4	3	2	1	0
		offset from S_BASE															
Address	0x04					0	0	0	0	0	0	0	0	0	1	0	
Data	write	x	x	x	x	x	x	x	x	x	x	x	x	x	sto	l15	sta

- sta=0 --
- sta=1 generate readout sequence (including Fast-Or, EFT, start,...)

- l15=0 do not send L1.5 accept
- l15=1 send L1.5 accept after readout

- sto=0 loop readout sequence forever (until sto=1 is set)
- sto=1 stop after current readout sequence

NB: The sto signal can either be issued together with sta (generating a single sequence) or at any later time (thus stopping after the current sequence has finished)

5.4.2 Simulate external test mode

		VME bus addr bits				...											
		31	30	29	28	11	10	9	8	7	6	5	4	3	2	1	0
		offset from S_BASE															
N_START	Address	0x10				0	0	0	0	0	0	0	1	0	0	0	
	Data	write	x	x	x	x	x	x	x	x	x	x	x	x	x	x	x
N_RESET	Address	0x14				0	0	0	0	0	0	0	1	0	1	0	
	Data	write	x	x	x	x	x	x	x	x	x	x	x	x	x	x	x

Initially, the FADCTF boards should be switched to test mode.
 A write operation to N_START generates a single ADCCLK5 window.
 The width of this window is 200ns for the first 4 calls, then 4x400ns, 4x600ns,...
 The number of stored samples depends on 5MHz (1,1,1,1,2,2,2,2,...) or
 20MHz (4,4,4,4,8,8,8,8,...) readout speed.
 A write operation to N_RESET resets the width of the clock window its initial state.

5.4.3 4-channel analog test output (RJ45)

NB: The front panel input signal is always added to the DAC output.

5.4.3.1 Automatic DAC ramp

		VME bus addr bits				...											
		31	30	29	28	11	10	9	8	7	6	5	4	3	2	1	0
		offset from S_BASE															
Address	0x20					0	0	0	0	0	0	1	0	0	0	0	
Data	write	x	x	x	x	x	x	x	x	x	x	x	x	x	x	x	r

- r=0 disable automatic DAC ramp
- r=1 enable automatic DAC ramp (200ns per step) during sequencer cycling

